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MOSFET

Metal Oxide Semiconductor Field Effect Transistor

CoolMOS™ CE

800V CoolMOS™ CE Power Transistor
IPx80R2K8CE

Data Sheet

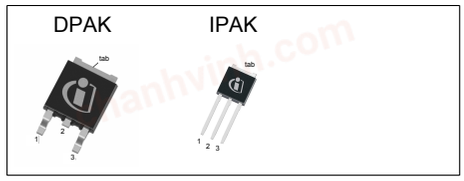
Rev. 2.3
Final

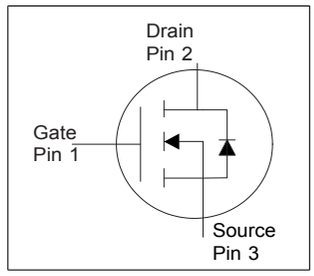
Power Management & Multimarket

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1 Description

CoolMOS™ CE is a revolutionary technology for high voltage power MOSFETs. The high voltage capability combines safety with performance and ruggedness to allow stable designs at highest efficiency level. CoolMOS™ 800V CE comes with a selected package choice offering the benefit of reduced system costs and higher power density designs.





Features

- High voltage technology
- Extreme dv/dt rated
- High peak current capability
- Low gate charge
- Low effective capacitances
- Qualified according to JEDEC Standard
- Pb-free lead plating; RoHS compliant; halogen free mold compound

Benefits

- Increased power density solutions due to smaller package
- System cost / size savings due to reduced cooling requirements
- Higher system reliability due to low operating temperatures

Applications

- LED Lighting for retrofit applications in QR Flyback topology

Table 1 Key Performance Parameters

Parameter	Value	Unit
V_{DS} @ $T_{j=25°C}$	800	V
$R_{DS(on),max}$	2.8	Ω
$Q_{g,typ}$	12	nC
$I_{D,pulse}$	6	A
$V_{GS(th),typ}$	3	V
$C_{O(tr),typ}$	26	pF

Type / Ordering Code	Package	Marking	Related Links
IPD80R2K8CE	PG-TO 252	8R2K8CE	see Appendix A
IPU80R2K8CE	PG-TO 251		

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2 Maximum ratings

at T_j = 25°C, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current [1]	I_D	- -	- -	1.9 1.1	A	T_C = 25°C T_C = 100°C
Pulsed drain current [2]	$I_{D,pulse}$	-	-	6	A	T_C=25°C
Avalanche energy, single pulse	E_{AS}	-	-	90	mJ	I_D =1A; V_{DD} = 50V
Avalanche energy, repetitive	E_{AR}	-	-	0.05	mJ	I_D =1A; V_{DD} = 50V
Avalanche current, repetitive	I_{AR}	-	-	1	A	-
MOSFET dv/dt ruggedness	dv/dt	-	-	50	V/ns	V_{DS} =0...640V
Gate source voltage	V_{GS}	-20 -30	- -	20 30	V	static; AC (f>1 Hz)
Power dissipation (non FullPAK) TO-252, TO-251	P_{tot}	-	-	42	W	T_C = 25°C
Operating and storage temperature	T_j, T_{stg}	-55	-	150	°C	-
Continuous diode forward current	I_S	-	-	1.9	A	T_C = 25°C
Diode pulse current [2]	$I_{S,pulse}$	-	-	6	A	T_C = 25°C
Reverse diode dv/dt [3]	dv/dt	-	-	4	V/ns	V_{DS} =0...400V, I_{SD}≤I_S, T_j=25°C
Maximum diode commutation speed	di_f/dt	-	-	400	A/µs	V_{DS} =0...400V, I_{SD}≤I_S, T_j=25°C

3 Thermal characteristics

Table 3 Thermal characteristics DPAK, IPAK

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}	-	-	3	°C/W	-
Thermal resistance, junction - ambient [4]	R_{thJA}	- -	- 35	62 -	°C/W	SMD version, device on PCB, minimal footprint SMD version, device on PCB, 6cm² cooling area [4]
Soldering temperature, wave- & reflowsoldering allowed	T_{sold}	-	-	260	°C	reflow MSL 1

[1] Limited by $T_{j\,max}$.
[2] Pulse width t_p limited by $T_{j,max}$
[3] Identical low side and high side switch with identical R_G
[4] Device on 40mm*40mm*1.5mm one layer epoxy PCB FR4 with 6cm² copper area (thickness 70µm) for drain connection. PCB is vertical without air stream cooling.

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4 Electrical characteristics

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	800	-	-	V	V_{GS}=0V, I_D=0.25mA
Gate threshold voltage	$V_{(GS)th}$	2.1	3	3.9	V	V_{DS}=V_{GS}, I_D=0.12mA
Zero gate voltage drain current	I_{DSS}	- -	- 25	5 -	µA	V_{DS}=800V, V_{GS}=0V, T_j=25°C V_{DS}=800V, V_{GS}=0V, T_j=150°C
Gate-source leakage curent	I_{GSS}	-	-	100	nA	V_{GS}=20V, V_{DS}=0V
Drain-source on-state resistance	$R_{DS(on)}$	- -	2.4 6.5	2.8 -	Ω	V_{GS}=10V, I_D=1.1A, T_j=25°C V_{GS}=10V, I_D=1.1A, T_j=150°C
Gate resistance	R_G	-	1.2	-	Ω	f=1 MHz, open drain

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	290	-	pF	V_{GS}=0V, V_{DS}=100V, f=1MHz
Output capacitance	C_{oss}	-	13	-	pF	V_{GS}=0V, V_{DS}=100V, f=1MHz
Effective output capacitance, energy related [1]	$C_{o(er)}$	-	11	-	pF	V_{GS}=0V, V_{DS}=0...480V
Effective output capacitance, time related [2]	$C_{o(tr)}$	-	26	-	pF	I_D=constant, V_{GS}=0V, V_{DS}=0...480V
Turn-on delay time	$t_{d(on)}$	-	25	-	ns	V_{DD}=400V, V_{GS}=0/10V, I_D=1.9A, R_G=47Ω
Rise time	t_r	-	15	-	ns	V_{DD}=400V, V_{GS}=0/10V, I_D=1.9A, R_G=47Ω
Turn-off delay time	$t_{d(off)}$	-	72	-	ns	V_{DD}=400V, V_{GS}=0/10V, I_D=1.9A, R_G=47Ω
Fall time	t_f	-	18	-	ns	V_{DD}=400V, V_{GS}=10 V, I_D=1.9A, R_G=47Ω

Table 6 Gate charge characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	1.5	-	nC	V_{DD}=640V, I_D=1.9A, V_{GS}=0 to 10V
Gate to drain charge	Q_{gd}	-	6	-	nC	V_{DD}=640V, I_D=1.9A, V_{GS}=0 to 10V
Gate charge total	Q_g	-	12	-	nC	V_{DD}=640V, I_D=1.9A, V_{GS}=0 to 10V
Gate plateau voltage	$V_{plateau}$	-	5.5	-	V	V_{DD}=640V, I_D=1.9A, V_{GS}=0 to 10V

[1] $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% $V_{(BR)DSS}$
[2] $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% $V_{(BR)DSS}$

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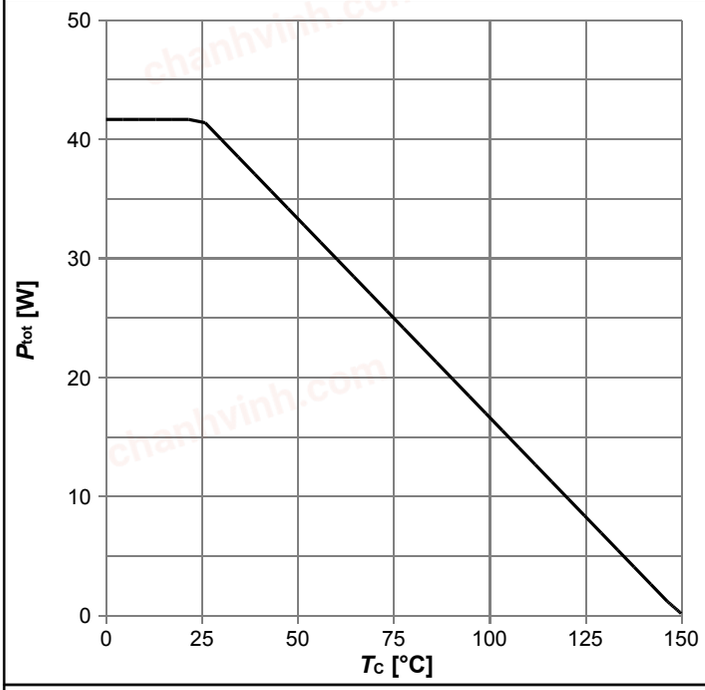
Table 7 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	V_{SD}	-	1	1.2	V	V_{GS}=0V, I_F=1.9A, T_j=25°C
Reverse recovery time	t_{rr}	-	520	-	ns	V_R=400V, I_F=1.9A, di_F/dt=100A/µs
Reverse recovery charge	Q_{rr}	-	2	-	µC	V_R=400V, I_F=1.9A, di_F/dt=100A/µs
Peak reverse recovery current	I_{rrm}	-	6	-	A	V_R=400V, I_F=1.9A, di_F/dt=100A/µs

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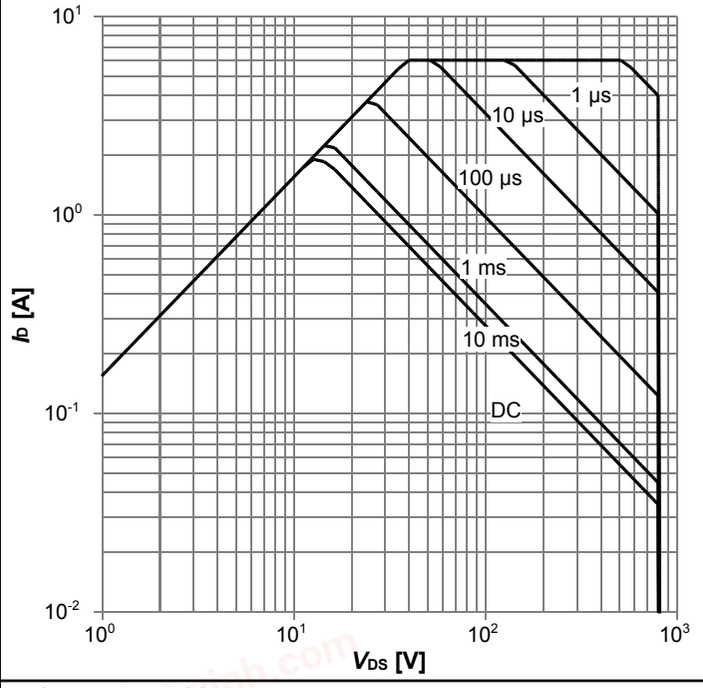
5 Electrical characteristics diagrams

Diagram 1: Power dissipation



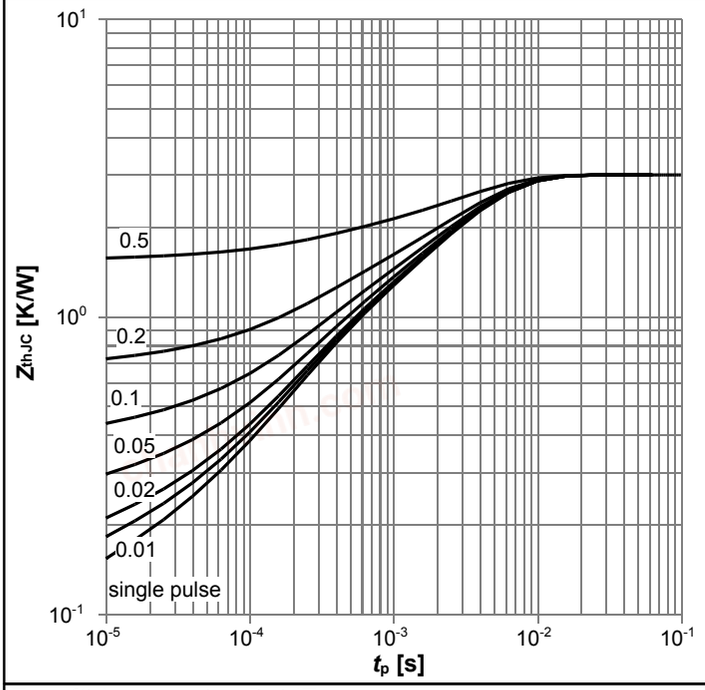
$P_{tot}=f(T_C)$

Diagram 2: Safe operating area



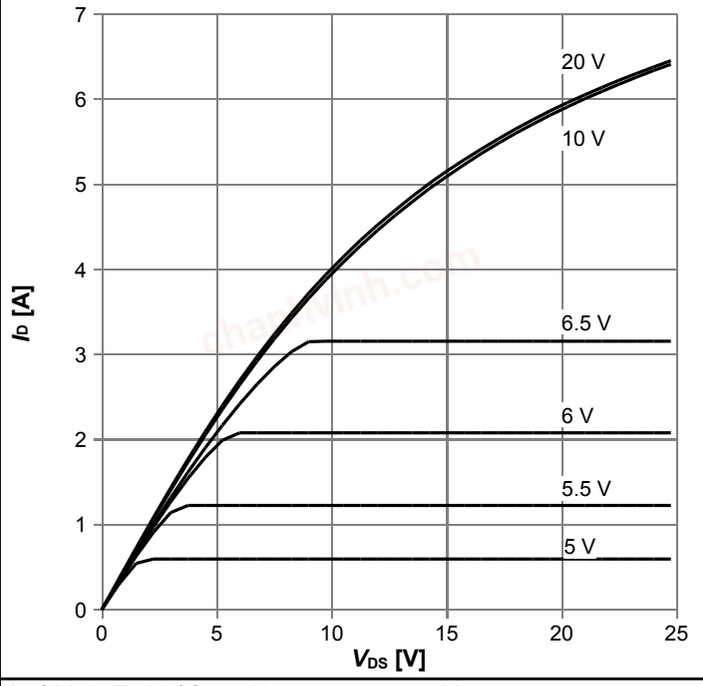
$I_D=f(V_{DS})$; T_C=25 °C; D=0; parameter: t_p

Diagram 3: Max. transient thermal impedance



$Z_{thJC}=f(t_P)$; parameter: $D=t_p/T$

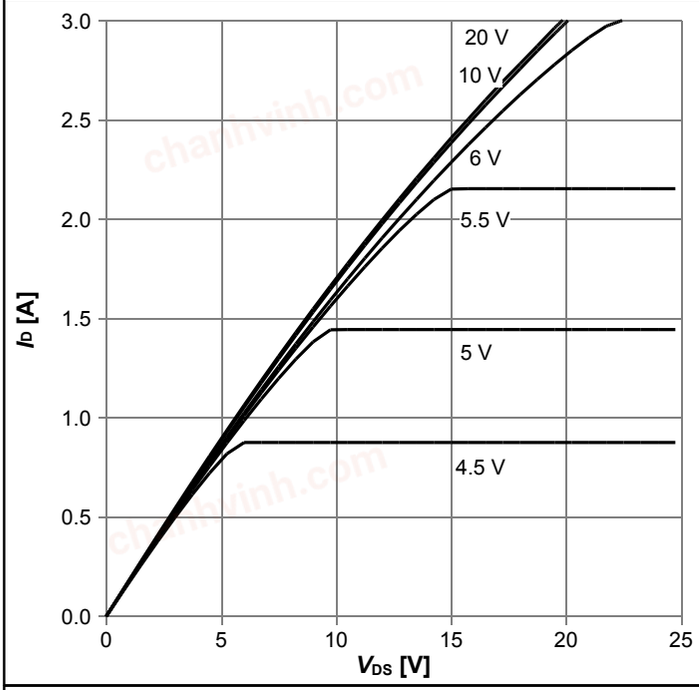
Diagram 4: Typ. output characteristics



$I_D=f(V_{DS})$; T_j=25 °C; t_p=10 µs; parameter: V_{GS}

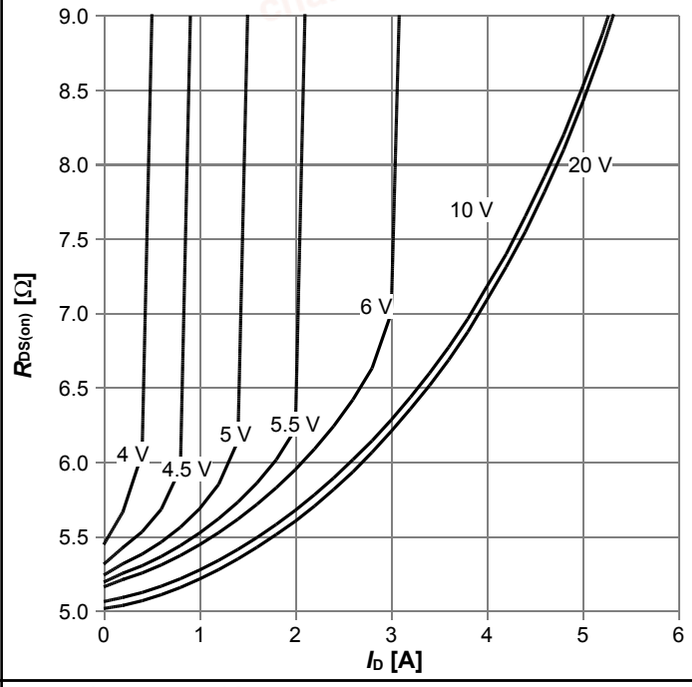
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Diagram 5: Typ. output characteristics



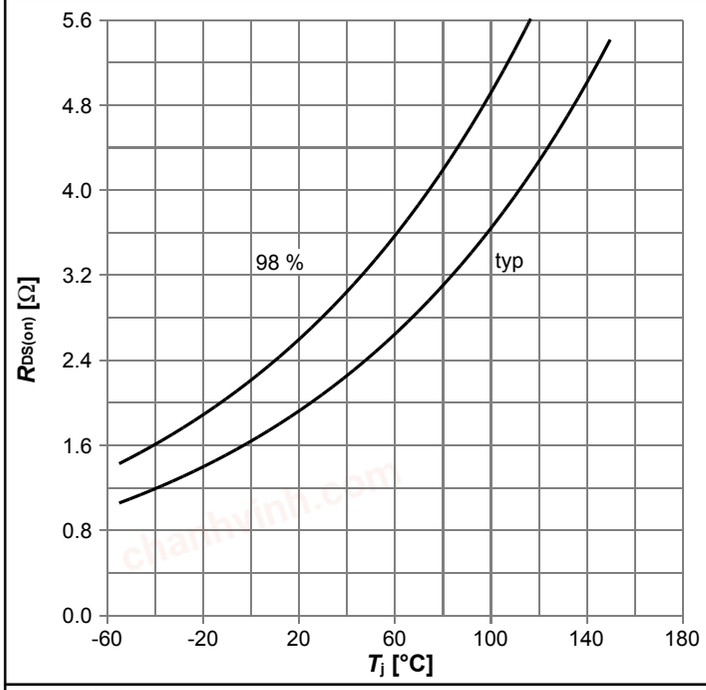
$I_D=f(V_{DS})$; $T_j=150$ °C; $t_p=10$ µs; parameter: V_{GS}

Diagram 6: Typ. drain-source on-state resistance



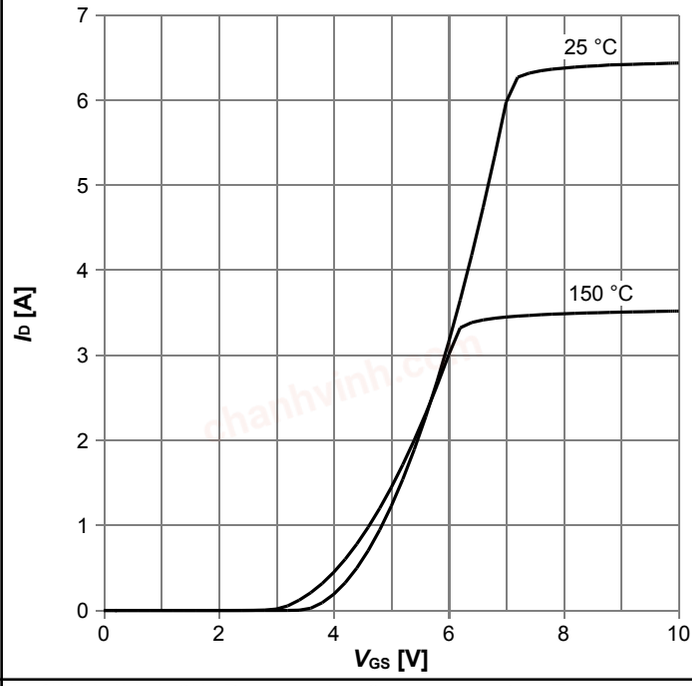
$R_{DS(on)}=f(I_D)$; $T_j=150$ °C; parameter: V_{GS}

Diagram 7: Drain-source on-state resistance



$R_{DS(on)}=f(T_j)$; $I_D=1.1$ A; $V_{GS}=10$ V

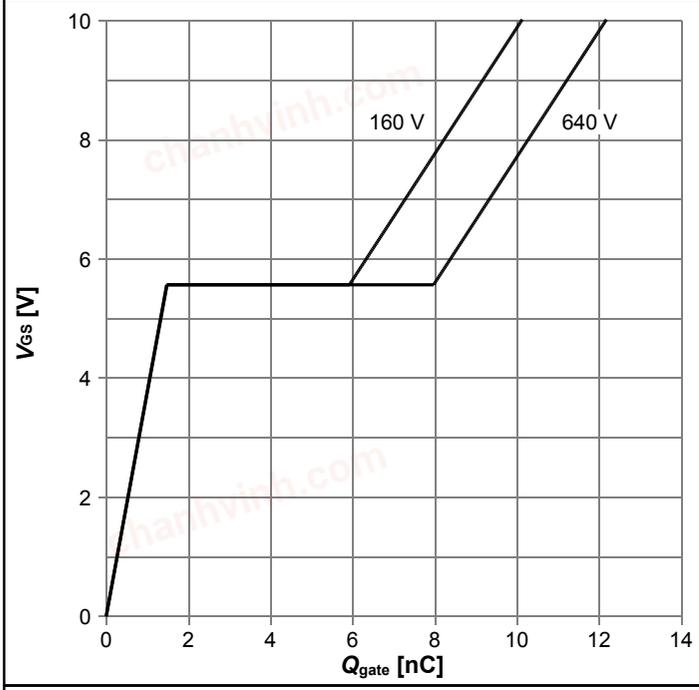
Diagram 8: Typ. transfer characteristics



$I_D=f(V_{GS})$; $|V_{DS}|>2|I_D|R_{DS(on)max}$; $t_p=10$ µs; parameter: T_j

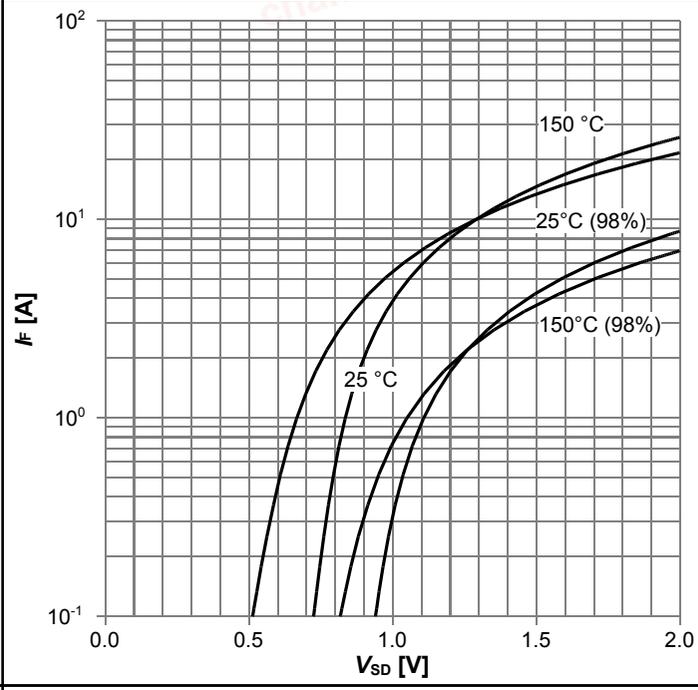
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Diagram 9: Typ. gate charge



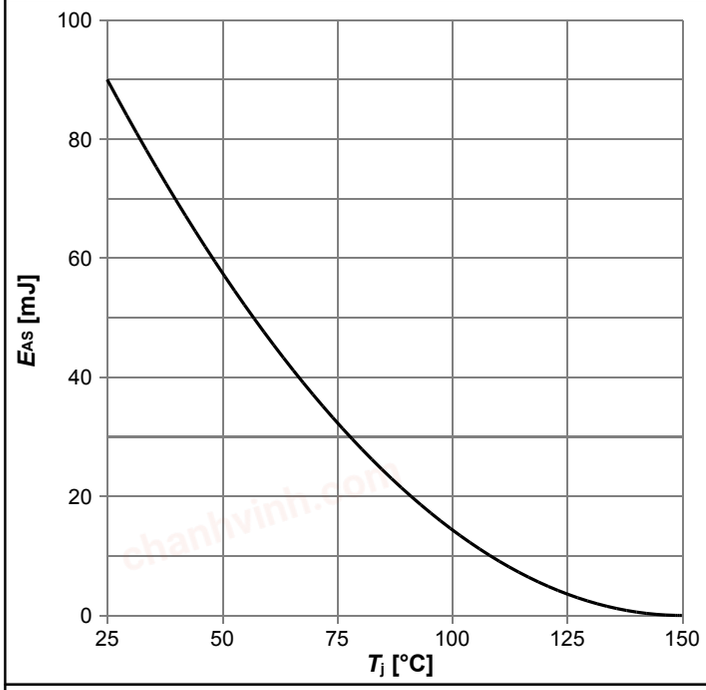
V_{GS}=f(Q_{gate}); I_D=1.9 A pulsed; parameter: V_{DD}

Diagram 10: Forward characteristics of reverse diode



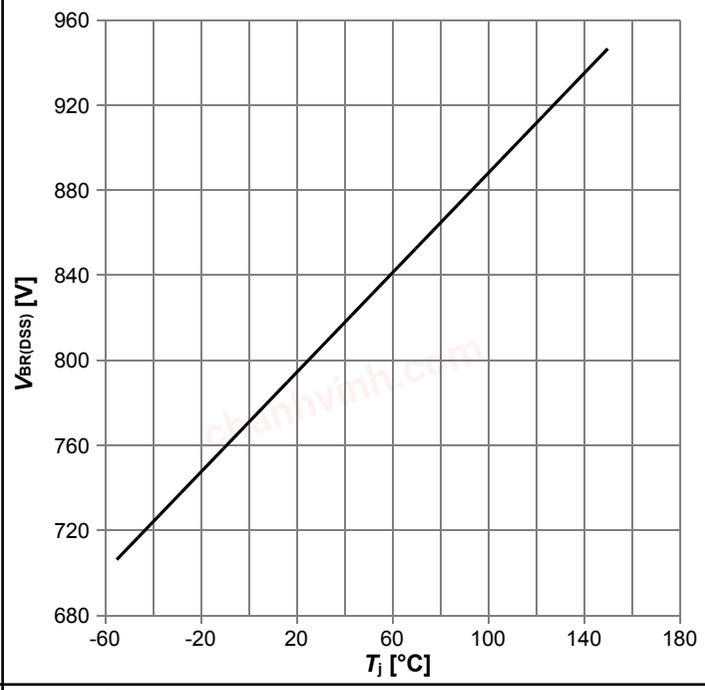
I_F=f(V_{SD}); t_p=10 µs; parameter: T_j

Diagram 11: Avalanche energy



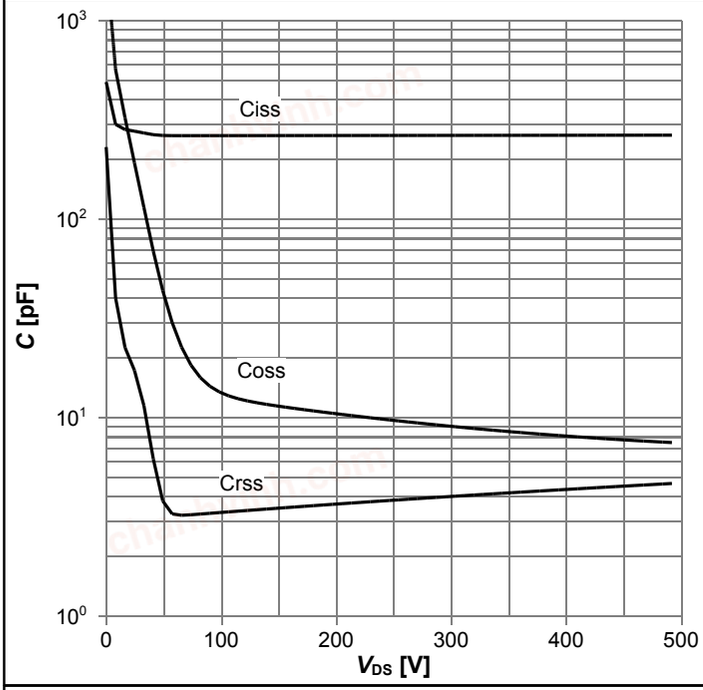
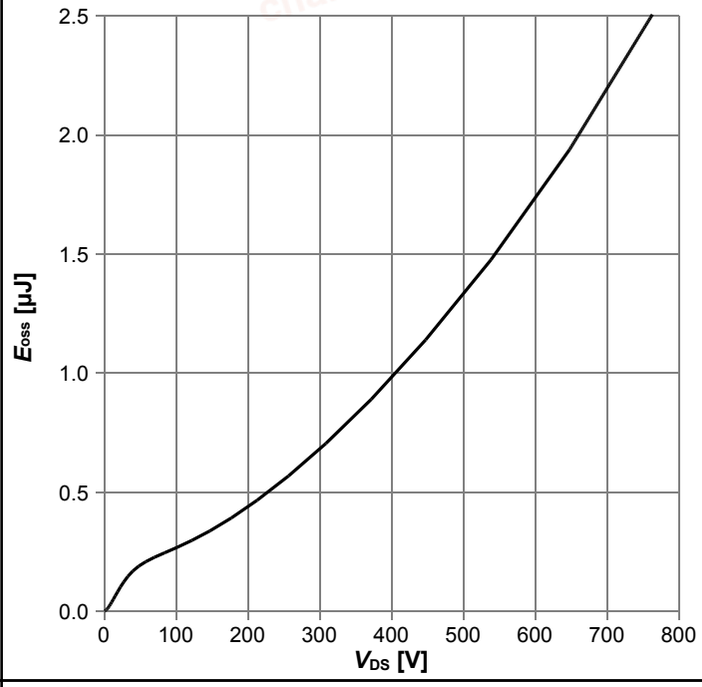
E_{AS}=f(T_j); I_D=1 A; V_{DD}=50 V

Diagram 12: Drain-source breakdown voltage



$V_{BR(DSS)}$=f(T_j); I_D=0.25 mA

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Diagram 13: Typ. capacitances	Diagram 14: Typ. Coss stored energy
	
C=f(V_{DS}); V_{GS}=0 V; f=1 MHz	E_{oss}=f(V_{DS})

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6 Test Circuits

Table 8 Diode characteristics

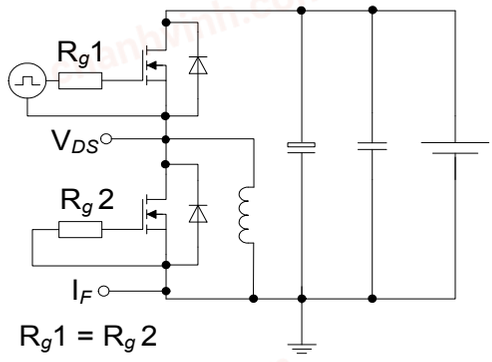
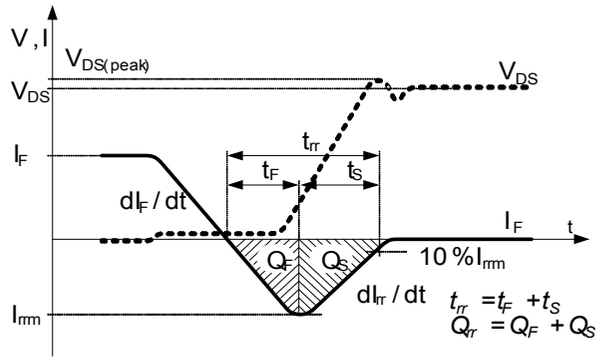
Test circuit for diode characteristics	Diode recovery waveform
	

Table 9 Switching times

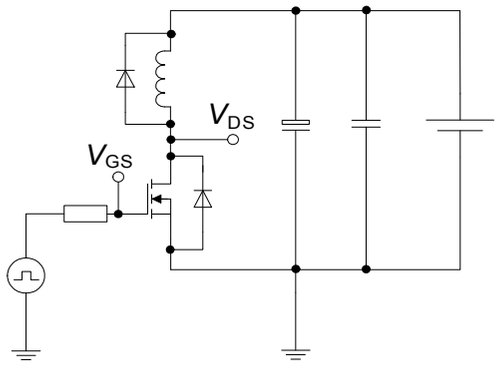
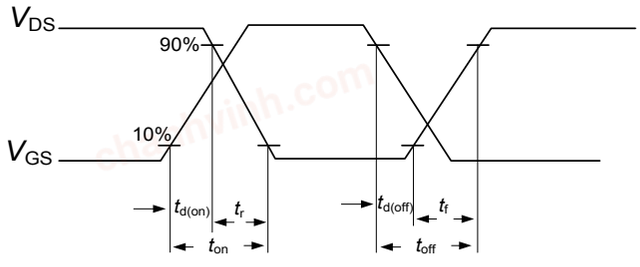
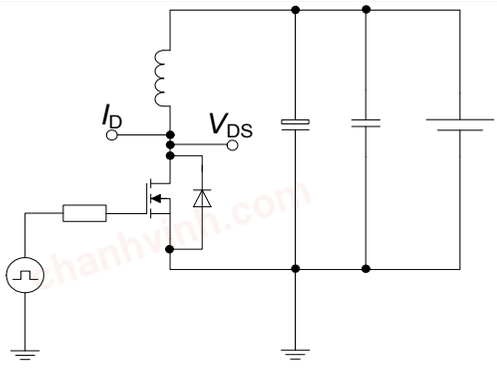
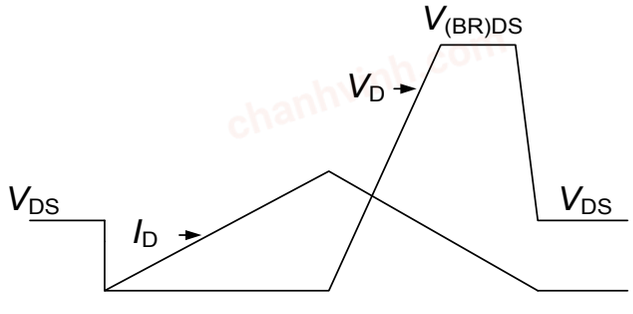
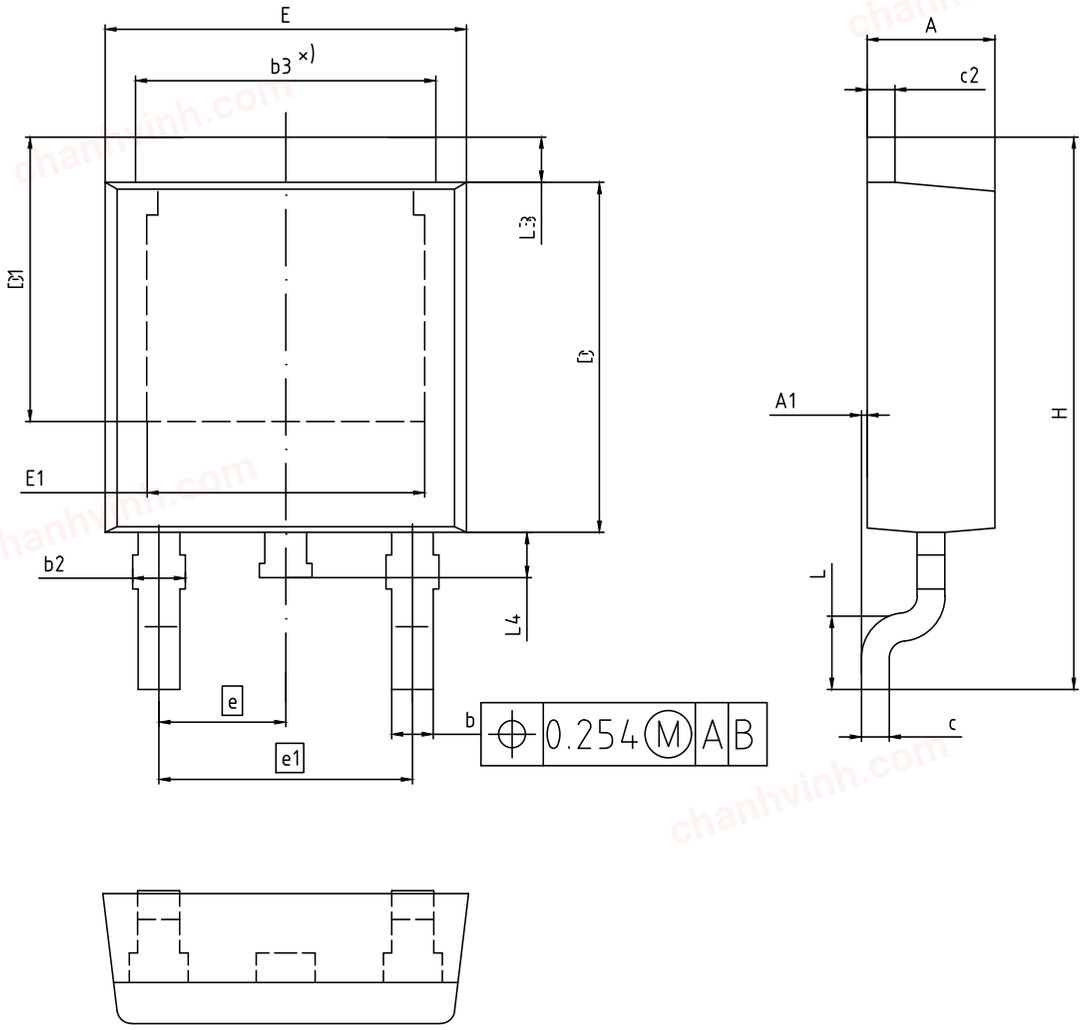
Switching times test circuit for inductive load	Switching times waveform
	

Table 10 Unclamped inductive load

Unclamped inductive load test circuit	Unclamped inductive waveform
	

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7 Package Outlines



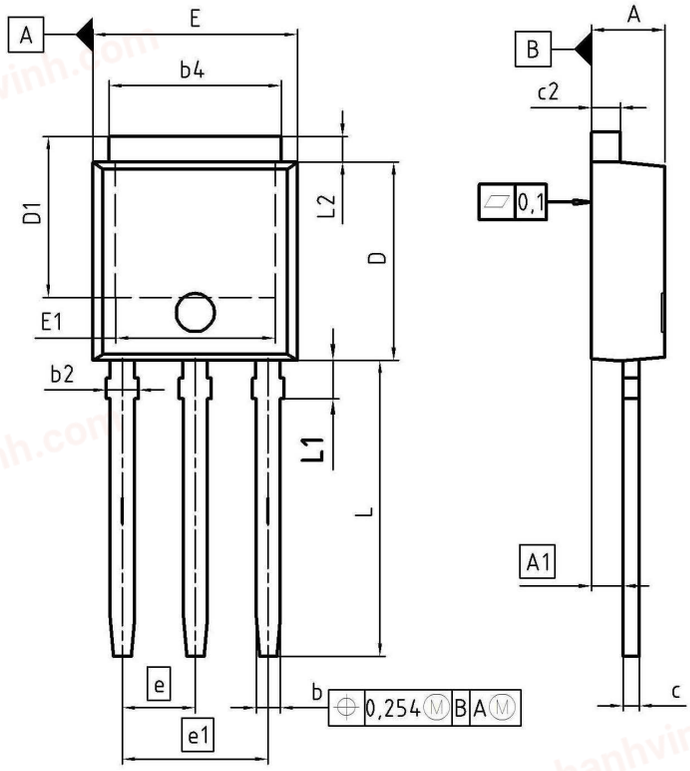
ALL DIMENSIONS REFER TO JEDEC STANDARD TO-252 AND DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS.

DIMENSION	MILLIMETERS	
	MIN.	MAX.
A	2.16	2.41
A1	0.00	0.15
b	0.64	0.89
b2	0.65	1.15
b3	4,95	5.50
c	0.46	0.61
c2	0.40	0.98
D	5.97	6.22
D1	5.02	5.84
E	6.35	6.73
E1	4.32	5.50
e	2.29	
e1	4.57	
N	3	
H	9.40	10.48
L	1.18	1.78
L3	0.89	1.27
L4	0.51	1.02

DOCUMENT NO.	Z8B00003328
REVISION	07
SCALE:	10:1 0 1 2mm
EUROPEAN PROJECTION	
ISSUE DATE	01.04.2020

Figure 1 Outline PG-TO 252, dimensions in mm

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DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.16	2.41	0.085	0.095
A1	0.90	1.14	0.035	0.045
b	0.64	0.89	0.025	0.035
b2	0.65	1.15	0.026	0.045
b4	4.95	5.50	0.195	0.217
c	0.46	0.60	0.018	0.024
c2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	5.04	5.77	0.198	0.227
E	6.35	6.73	0.250	0.265
E1	4.70	5.21	0.185	0.205
e	2.29		0.090	
e1	4.57		0.180	
N	3		3	
L	8.89	9.65	0.350	0.380
L1	1.90	2.29	0.075	0.090
L2	0.89	1.37	0.035	0.054

DOCUMENT NO.
Z8B00003330

SCALE 0 2.0 0 2.0 4mm

EUROPEAN PROJECTION

ISSUE DATE
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REVISION
03

Figure 2 Outline PG-TO 251, dimensions in mm/inches

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8 Appendix A

Table 11 Related Links

- **IFX CoolMOS Webpage:** www.infineon.com
- **IFX Design tools:** www.infineon.com

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Revision History

IPx80R2K8CE

Revision: 2020-05-26, Rev. 2.3

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2013-06-24	Release of final version
2.1	2013-07-18	update to halogen free mold compound
2.2	2016-04-27	Non-halogen free version discontinued
2.3	2020-05-26	Update of the package outlines TO-252

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